

Notice of References Cited		Application/Control No. 09/929,995	Applicant(s)/Patent Under Reexamination TERNULLO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0087596	07-2002	Lewontin, Steve	707/513
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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